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8001-1141

PATENTS

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Tomohiro SAKAI

Confirmation No. 2260

Serial No. 09/883,328

Group 2651

Filed June 19, 2001

LOOP DIAGNOSIS SYSTEM AND METHOD FOR DISK ARRAY APPARATUSSES

INFORMATION DISCLOSURE STATEMENT

RECEIVED

Commissioner for Patents

APR 15 2003

Washington, D.C. 20231

Technology Center 2600

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the accompanying documents, copies of which are attached to this statement, are made of record on the enclosed sheet.

A concise explanation of the relevance of these items is that these references were cited by the Japanese Patent Office in the corresponding Japanese Application Serial No. 2000-185588, filed June 21, 2000. A copy of the Japanese Official Action in which they were cited is attached hereto, with what is believed to be the pertinent portion enclosed in a wavy line. An English translation of the enclosed portion is also attached hereto.

Under the provisions of 37 CFR 1.97(e), the undersigned hereby certifies that each item of information contained in this Information Disclosure Statement was first cited in any communication from a foreign Patent Office in a

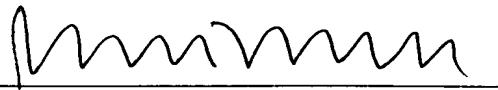
S.N. 09/883,328

counterpart foreign application not more than three months prior to the filing of this Statement.

Respectfully submitted,

YOUNG & THOMPSON

By



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April 14, 2003

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
8001-1141

SERIAL NO.
09/883,328

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

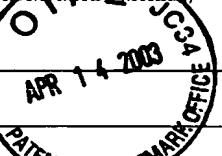
(Use several sheets if necessary)

37 CFR 1.98(b)

APPLICANT
Tomohiro SAKAI

FILING DATE
June 19, 2001

GROUP
2651



U.S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT & TRADEMARK OFFICE PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AA						
AB						
AC						
AD						

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

	DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
AI	A 5-128040	05/93	JP			
AJ	A 2000-99272	04/00	JP			
AK	A 8-263224	10/96	JP			
AL						RECEIVED APR 15 2003
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AO						
AP						
AQ						

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

AT	
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EXAMINER

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.